

Notice of References Cited	Application/Control No. 10/758,855	Applicant(s)/Patent Under Reexamination HEIKKILA ET AL.	
	Examiner Magda Cruz	Art Unit 2851	Page 1 of 1

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*	B	US-6,844,967	01-2005	Teramoto et al.	359/443
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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